MSKSEMI















ESD

TVS

TSS

MOV

GDT

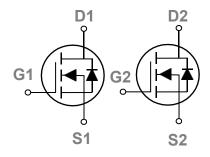
PLED

Broduct data sheet



SOT23-6 Dual Pin Configuration





Features

- 20V, 3.5A, $RDS(ON) = 50m\Omega@VGS = 4.5V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

Applications

- Notebook
- Load Switch
- Hend-Held Instruments

BVDSS	RDSON	ID
20V	50m $Ω$	3.5A

Absolute Maximum Ratings Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	20	V
V _G s	Gate-Source Voltage	±12	V
	Drain Current – Continuous (T _A =25°C)	3.5	А
lD	Drain Current – Continuous (T _A =70°C)	2.9	А
Ірм	Drain Current – Pulsed ¹	14.4	А
D	Power Dissipation (T _A =25°C)	1.25	W
P _D	Power Dissipation – Derate above 25°C	0.01	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
Reja	Thermal Resistance Junction to ambient		100	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.02		V/°C
	Dunin Course Leakens Cumant	V _{DS} =20V , V _{GS} =0V , T _J =25°C			1	uA
IDSS	Drain-Source Leakage Current	V _{DS} =16V , V _{GS} =0V , T _J =125°C			10	uA
Igss	Gate-Source Leakage Current	V _{GS} =±12V , V _{DS} =0V			±100	nA

On Characteristics

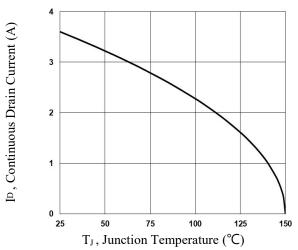
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =3A		50	60	mΩ
1.55(6.11)	Ciatio Brain Godroc Cir Nociotarios	V _{GS} =2.5V , I _D =2A		60	80	11152
V _{GS(th)}	Gate Threshold Voltage	\/\/	0.4	0.8	1.2	V
$\Delta V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	Coefficient V _{GS} =V _{DS} , I _D =250uA		2		mV/°C
gfs	Forward Transconductance	V _{DS} =10V , I _S =2A		4.4		S

Dynamic and switching Characteristics

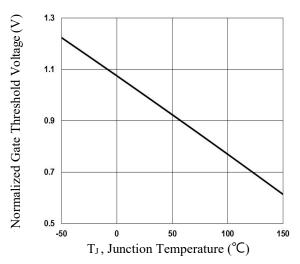
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Qg	Total Gate Charge ^{2,3}		 3.6	
Q_{gs}	Gate-Source Charge ^{2, 3}	V _{DS} =10V , V _{GS} =4.5V , I _D =1A	 0.38	 nC
Q_{gd}	Gate-Drain Charge ^{2, 3}		 0.6	
$T_{d(on)}$	Turn-On Delay Time ^{2, 3}		 1.8	
Tr	Rise Time ^{2, 3}	V_{DD} =10V , V_{GS} =4.5V , R_{G} =25 Ω	 5.6	 6
$T_{d(off)}$	Turn-Off Delay Time ^{2, 3}	I _D =1A	 11.3	 nS
T _f	Fall Time ^{2, 3}		 3.2	
C _{iss}	Input Capacitance		 180	
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V , F=1MHz	 32	 pF
C _{rss}	Reverse Transfer Capacitance		 26	

Drain-So						
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current	VVOV Force Current			3.5	Α
Ism	Pulsed Source Current	V _G =V _D =0V , Force Current			7.0	Α
V _{SD}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

PACKAGE MECHANICAL DATA



Continuous Drain Current vs. T_J



Normalized Vth vs. TJ Fig.3

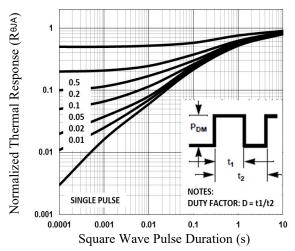
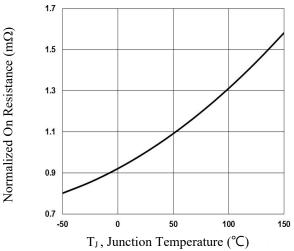
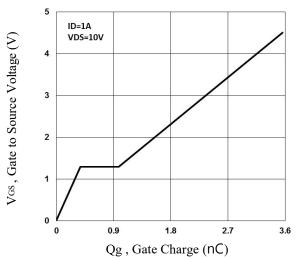


Fig.5 Normalized Transient Impedance



Normalized RDSON vs. T_J Fig.2



Gate Charge Waveform

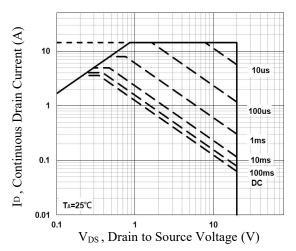
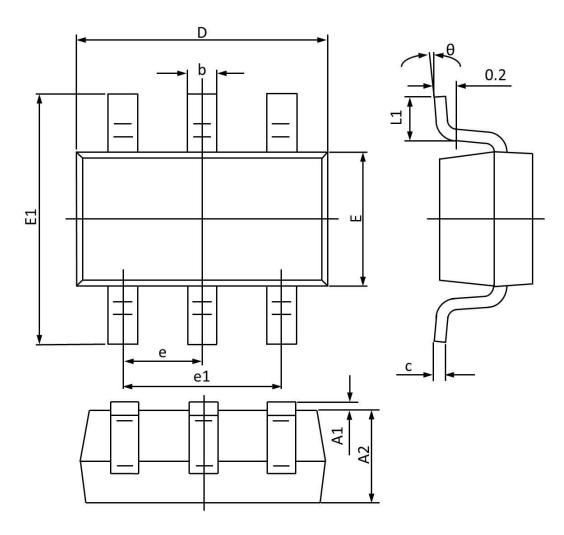


Fig.6 Maximum Safe Operation Area





Symbol	Dimensions 1	n Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
A1	0.000	0.100	0.000	0.004
A2	1.000	1.200	0.040	0.047
b	0.300	0.500	0.012	0.019
c	0.047	0.207	0.002	0.008
D	2.800	3.000	0.110	0.118
E	1.500	1.800	0.059	0.070
E1	2.600	3.000	0.103	0.118
e	0.950 TYP		0.037 TYP	
e1	1.900) TYP	0.075 TYP	
L1	0.250	0.550	0.010	0.021
θ	0°	8°	0°	8°

REEL SPECIFICATION

P/N	PKG	QTY
FDC6401N	SOT-23-6	3000



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